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026418

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney's Docket No.:

GK-ZEI-3161 / 500343.20162

U.S. Application No.:

International Application No.:

PCT/EP01/09049

International Filing Date:

AUGUST 04, 2001

04 AUGUST 2001

Priority Date Claimed:

AUGUST 08, 2000

08 AUGUST 2000

Title of Invention:

ASSEMBLY FOR INCREASING THE DEPTH DISCRIMINATION OF

AN OPTICAL IMAGING SYSTEM (Anordnung zue Erhöhung der Tiefendisk- riminierung Optisch Abbildender Systeme)

Applicant(s) for (DO/EO/US):

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Commissioner of Patents Washington, D. C. 20231

INFORMATION DISCLOSURE STATEMENT

SIR:

Applicant herewith submits together with the simultaneously filed National Phase application of PCT/EP00/09049,a copy of the International Search Report (PCT/ISA/210) dated February 5, 2002 and German Examination Report dated January 3, 2001 citing the following references:

	Document Number	Date	Name and/or Country	English Translation
AA	4,984,893	01/15/1991	Lange	
AL	34 13 605 -	10/17/1985	Germany	Abstract only
AM	41 29 796 -	04/01/1993	Germany	Abstract only
AN	7-159324 -	06/23/1995	Japan	Abstract only
AO	WO 98/45745	-10/15/1998	WIPO	

Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the documents.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,

GHK:ram 04/03/02

Tel. (212) 521-5400

Enclosures:

Search Report (PCT/ISA/210); German Examination Report

PTO-1449;

5 documents including 3 English Abstracts

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